

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
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		Examiner	Art Unit	Page 1 of 1
		Douglas S. Lee	2125	

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*	B	US-5,050,088	09-1991	Buckler et al.	700/96
*	C	US-6,564,113	05-2003	Barto et al.	700/99
*	D	US-6,731,998	05-2004	Walser et al.	700/99
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	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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